

MOSFET - N-Channel, QFET

150 V, 70 A, 28 m Ω

FQA70N15

Description

This N-Channel enhancement mode power MOSFET is produced using **onsemi**'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on–state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, DC motor control, and variable switching power applications.

Features

- 70 A, 100 V, $R_{DS(on)} = 28 \text{ m}\Omega$ (Max) @ $V_{GS} = 10 \text{ V}$, $I_D = 35 \text{ A}$
- Low Gate Charge (Typ. 135 nC)
- Low Crss (Typ. 135 pF)
- 100% Avalanche Tested
- This is a Pb-Free Device

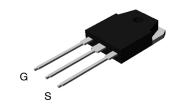
ABSOLUTE MAXIMUM RATINGS

(T_C = 25°C unless otherwise noted)

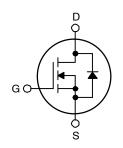
| Symbol | Parameter | FQA70N15 | Unit |
|-----------------------------------|--|-------------|-----------|
| V _{DSS} | Drain to Source Voltage | 150 | V |
| I _D | Drain Current Continuous (T _C = 25°C) Continuous (T _C = 100°C) | 70 50 | Α |
| I _{DM} | Drain Current – Pulsed (Note 1) | 250 | Α |
| V_{GSS} | Gate to Source Voltage | ±25 | V |
| E _{AS} | Single Pulsed Avalanche Energy (Note 2) | 1000 | mJ |
| I _{AR} | Avalanche Current (Note 1) | 70 | Α |
| E _{AR} | Repetitive Avalanche Energy (Note 1) | 33 | mJ |
| dv/dt | Peak Diode Recovery dv/dt (Note 3) | 6.0 | V/ns |
| P _D | Power Dissipation (T _C = 25°C) – Derate above 25°C | 330 2.2 | W W/°C |
| T _J , T _{STG} | Operating and Storage Temperature Range | -55 to +175 | °C |
| TL | Maximum Lead Temperature for Soldering Purposes, 1/8" from Case for 5 Seconds | 300 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. L = 0.34 mH, I_{AS} = 70 A, V_{DD} = 25 V, R_{G} = 25 Ω , Starting T_{J} = 25°C.
- 3. $I_{SD} \le 70$ A, di/dt ≤ 300 A/ μ s, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25$ °C.



TO-3P-3LD / EIAJ SC-65, ISOLATED CASE 340BZ



MARKING DIAGRAM

&Z&3&K FQA 70N15

&Z = Assembly Location

&3 = Date Code (Year and Week)

&K = Lot Code

FQA70N15 = Specific Device Code

ORDERING INFORMATION

| Device | Package | Shipping [†] |
|----------|--------------------|-----------------------|
| FQA70N15 | TO-3P (Pb-Free) | 450 / Tube |

THERMAL CHARACTERISTICS

| Symbol | Parameter | FQA70N15 | Unit |
|-----------------|--|----------|------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case, Max | 0.45 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient, Max | 40 | °C/W |

ELECTRICAL CHARACTERISTICS (T_C = 25°C, unless otherwise noted)

| Symbol | Parameter Test Conditions | | Min | Тур | Max | Unit |
|----------------------------------|--|--|-----|-------|-------|------|
| OFF CHAR | ACTERISTIC | | | | | - |
| BV _{DSS} | Drain to Source Breakdown Voltage | $I_D = 250 \mu A, V_{GS} = 0 V$ | 150 | - | - | V |
| $\Delta BV_{DSS} / \Delta T_{J}$ | Breakdown Voltage Temperature Coefficient | I _D = 250 μA, Referenced to 25°C | - | 0.15 | - | V/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 150 V, V _{GS} = 0 V | - | _ | 1 | μΑ |
| | | V _{DS} = 120 V, T _C = 150°C | _ | - | 10 | 1 |
| I _{GSSF} | Gate to Body Leakage Current, Forward | V _{GS} = 25 V, V _{DS} = 0 V | _ | - | 100 | nA |
| I _{GSSR} | Gate to Body Leakage Current, Reverse | $V_{GS} = -25 \text{ V}, V_{DS} = 0 \text{ V}$ | _ | - | -100 | |
| ON CHARA | CTERISTICS | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_D = 250 \mu A$ | 2.0 | - | 4.0 | V |
| R _{DS(on)} | Static Drain to Source On-Resistance | V _{GS} = 10 V, I _D = 35 A | - | 0.023 | 0.028 | Ω |
| 9FS | Forward Transconductance | V _{DS} = 40 V, I _D = 35 A | _ | 48 | - | S |
| DYNAMIC (| CHARACTERISTICS | | • | | • | • |
| C _{iss} | Input Capacitance | $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ | - | 4150 | 5400 | pF |
| C _{oss} | Output Capacitance | f = 1.0 MHz | _ | 840 | 1100 | pF |
| C _{rss} | Reverse Transfer Capacitance | 1 | _ | 135 | 175 | pF |
| SWITCHING | G CHARACTERISTICS | | • | | | |
| t _{d(on)} | Turn-On Delay Time | V _{DD} = 75 V, I _D = 70 A, | _ | 60 | 130 | ns |
| t _r | Turn-On Rise Time | $R_G = 25 \Omega$ (Note 4) | _ | 420 | 850 | ns |
| t _{d(off)} | Turn-Off Delay Time |] | - | 340 | 690 | ns |
| t _f | Turn-Off Fall Time |] | - | 290 | 590 | ns |
| Qg | Total Gate Charge | $V_{DS} = 120 \text{ V}, I_D = 70 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 4) | - | 135 | 175 | nC |
| Q _{gs} | Gate to Source Charge | | - | 25 | - | nC |
| Q _{gd} | Gate to Drain Charge | (1111) | - | 65 | - | nC |
| DRAIN-SO | URCE DIODE CHARACTERISTICS AND M | AXIMUM RATINGS | | | | |
| I _S | Maximum Continuous Drain to Source Diode Forward Current | | _ | _ | 70 | Α |
| I _{SM} | Maximum Pulsed Drain to Source Diode Forward Current | | - | - | 280 | Α |
| V _{SD} | Drain to Source Diode Forward Voltage | V _{GS} = 0 V, I _S = 70 A | | - | 1.5 | V |
| t _{rr} | Reverse Recovery Time | V _{GS} = 0 V, I _S = 70 A, | - | 150 | - | ns |
| Q _{rr} | Reverse Recovery Charge | dl _F /dt = 100 A/μs | _ | 0.67 | - | μС |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Essentially independent of operating temperature.

TYPICAL CHARACTERISTICS

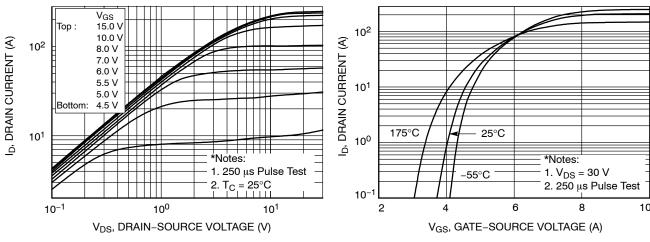


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics

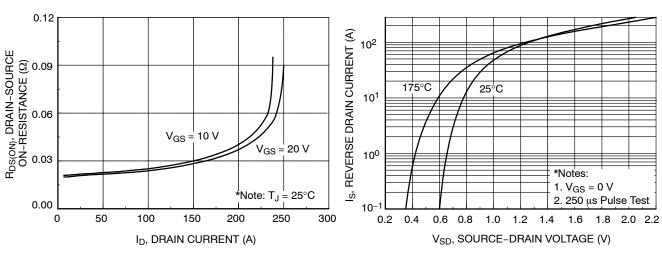


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

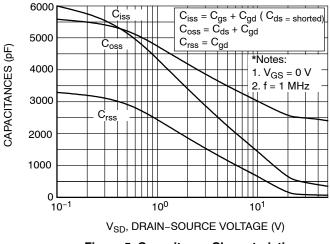


Figure 5. Capacitance Characteristics

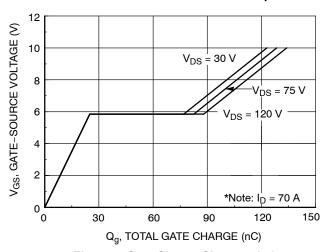
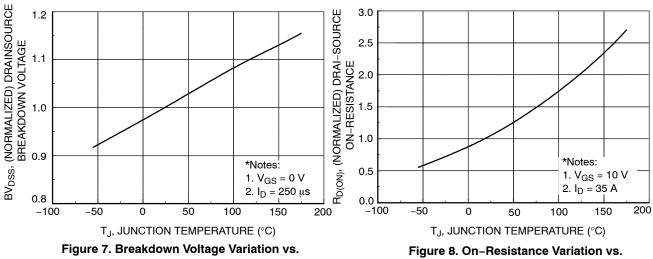


Figure 6. Gate Charge Characteristics

TYPICAL CHARACTERISTICS (CONTINUED)



Temperature

Temperature

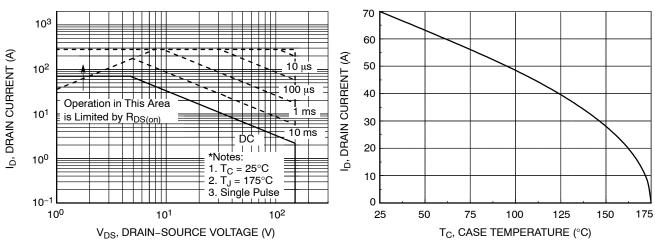


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case **Temperature**

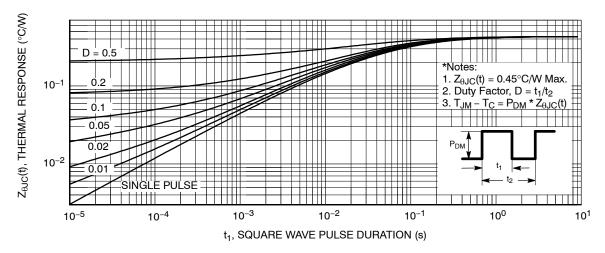


Figure 11. Transient Thermal Response Curve

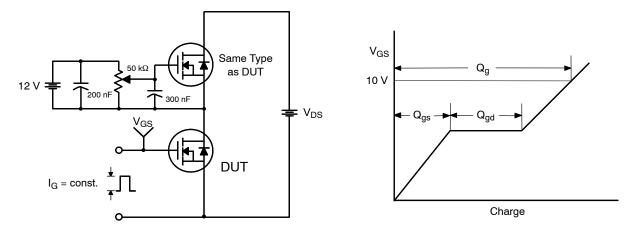


Figure 12. Gate Charge Test Circuit & Waveform

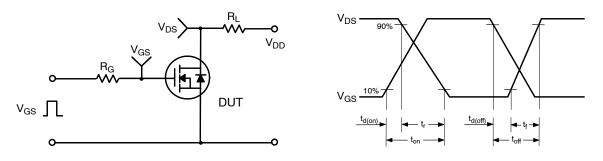


Figure 13. Resistive Switching Test Circuit & Waveforms

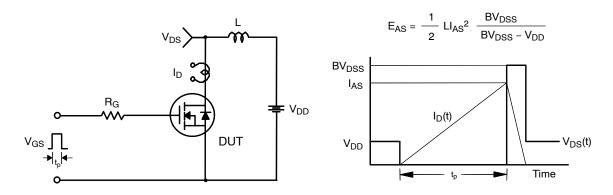
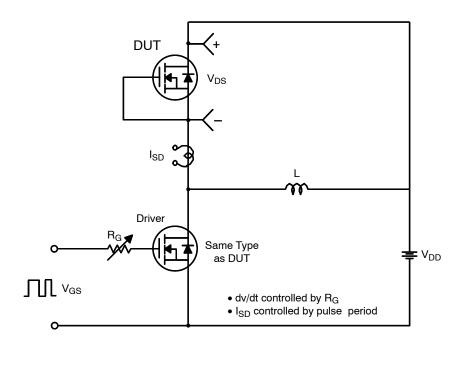


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



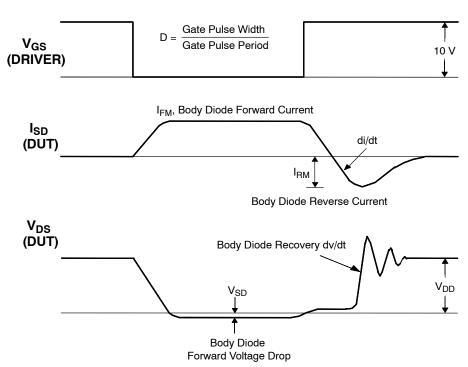
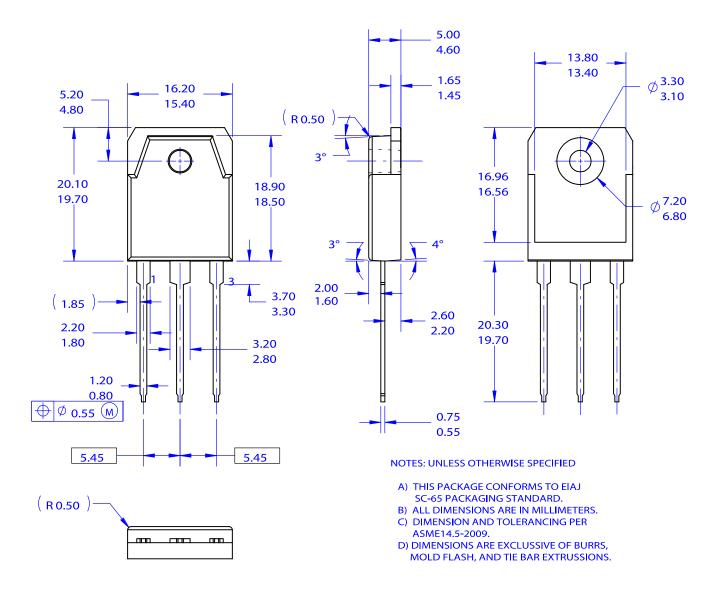


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



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DATE 31 OCT 2016



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